

Supporting information

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Experimental Section:

Fabrication of ZnO seed layer and ZnO NRs on FTO substrate: First, clean the FTO substrate. Wipe the surface of the FTO substrate with cotton, and then ultrasonically wash using detergent, deionized water, acetone, isopropanol and absolute ethanol for 10 minutes to remove residual impurities and grease, finally dry at 80 °C in a drying oven. The sol-gel method is used to prepare ZnO seed layer. The specific implementation steps are as follows: take 0.0125 mol of zinc acetate dihydrate ($C_4H_{10}O_6Zn$) to dissolve in 25 ml of ethylene glycol methyl ether, and add 0.75 ml of ethanolamine as a stabilizer, sustained stir for 3 h at 60 °C. A stable, transparent and clear ZnO sol solution is obtained. ZnO seed layer on the FTO substrate is prepared by the spin-coating method at 3000 rpm for 20 s and annealed at 400 °C for 15 min. After repeated the process, ZnO seed layer is annealed at 400 °C for 30 min. The chemical bath deposition (CBD) method is used to grow ZnO NRs on ZnO seed film. The specific steps are as follows: separately prepare 0.1 M hexamethylenetetramine ($C_6H_{12}N_4$) and 0.15 M hexahydrate nitric acid ($Zn (NO_3)_2 \cdot 6H_2O$) aqueous solutions and mix them at 80 °C, and then immerse the ZnO seed layer film vertically in the solution and grow for 3 h. The sample are taken out and washed repeatedly with deionized water, finally dried at 80 °C.

Preparation of Cu₂O film: Dissolve 20 g of $CuSO_4 \cdot 5H_2O$ in a certain amount of deionized water, magnetically stir for 30 min, add 44.82 ml of lactic acid, and then add an appropriate amount of deionized water to 200 ml. Continue magnetic stirring for 30 min, and adjust the pH to 10.5 with 5 M NaOH solution. A three-electrode electrochemical system is adopted with ZnO NRs as the working electrode, platinum-titanium mesh as the counter electrode and Ag/AgCl as the reference electrode. Cu₂O thin film is electrochemically pulse-deposited using the cathode reduction method. The deposition current sets 9 mA with the deposition time interval of 60 s and deposition temperature of 60 °C for 6 times. Then, 0.005 mol, 0.01 mol and 0.02 mol Na₂EDTA were added into the electrolyte solution respectively and the pH value of the electrolyte keeps unchanged.

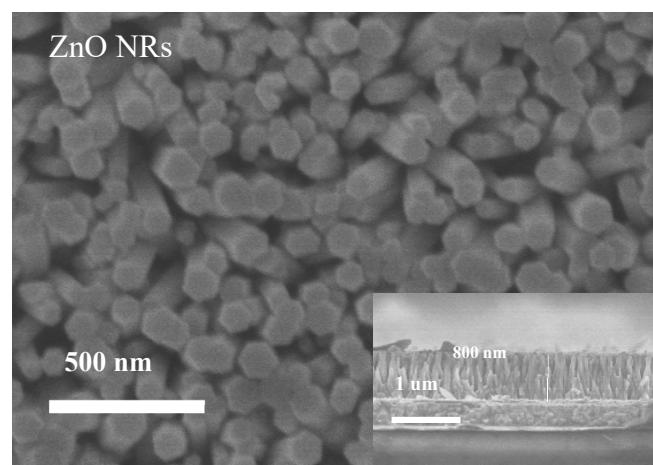


Fig.S1 The top-view and cross-sectional view of ZnO NRs

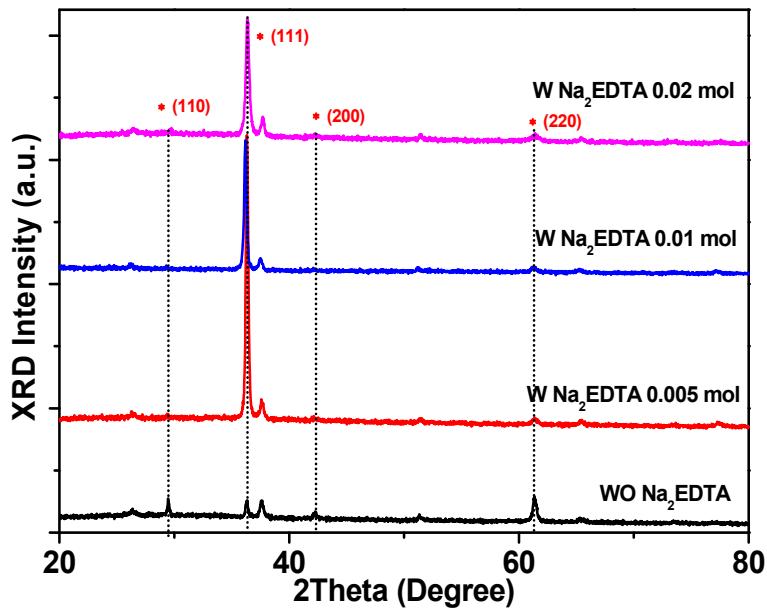


Fig.S2 XRD patterns of Cu₂O films prepared on FTO substrates with different Na₂EDTA contents

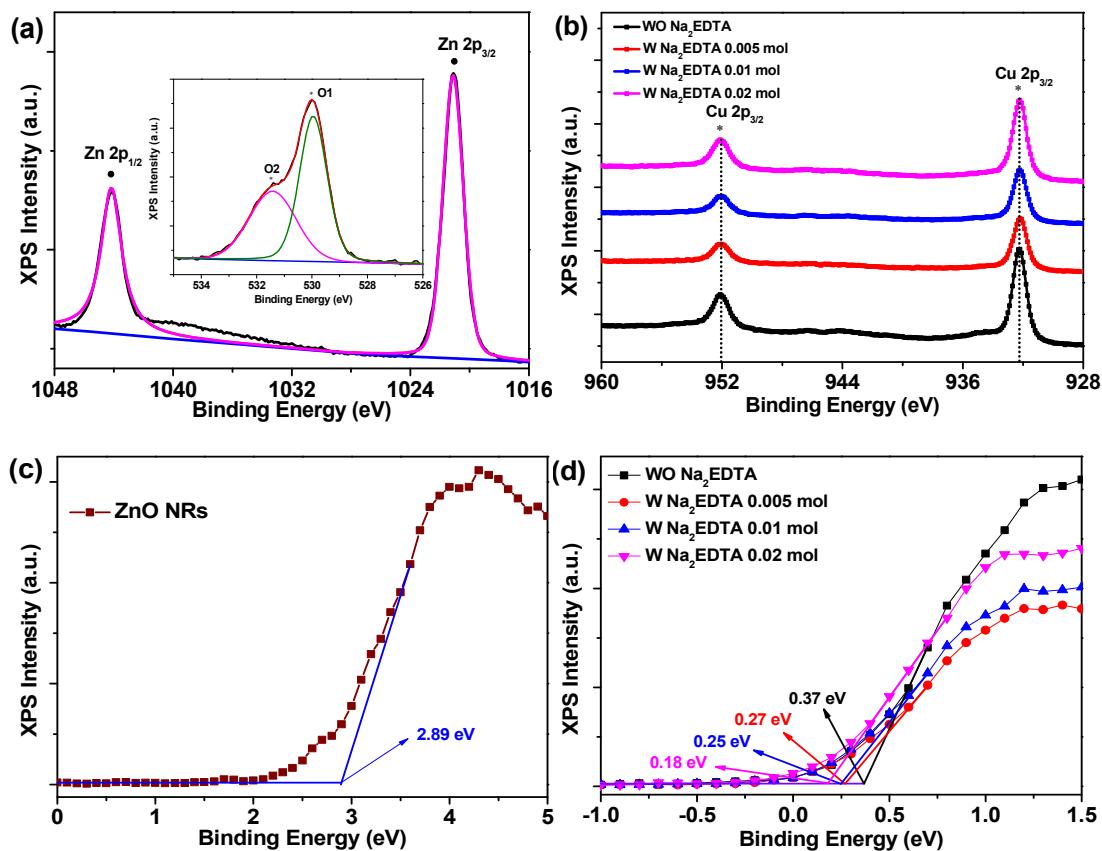


Fig.S3 (a) XPS spectra of Zn 2p and (b) Cu 2p for ZnO/Cu₂O heterostructures prepared under different Na₂EDTA additions. The inset is O1s XPS spectra for ZnO NRs. (c) Valence band spectra of ZnO NRs and (d) ZnO/Cu₂O heterostructures prepared under different Na₂EDTA additions.

Table 1 Cu/O ratio of Cu₂O thin films prepared with different Na₂EDTA contents

Samples (Na ₂ EDTA content)	Cu/O ratio
0	0.82
0.005 mol	1.70
0.01 mol	0.87
0.02 mol	1.32

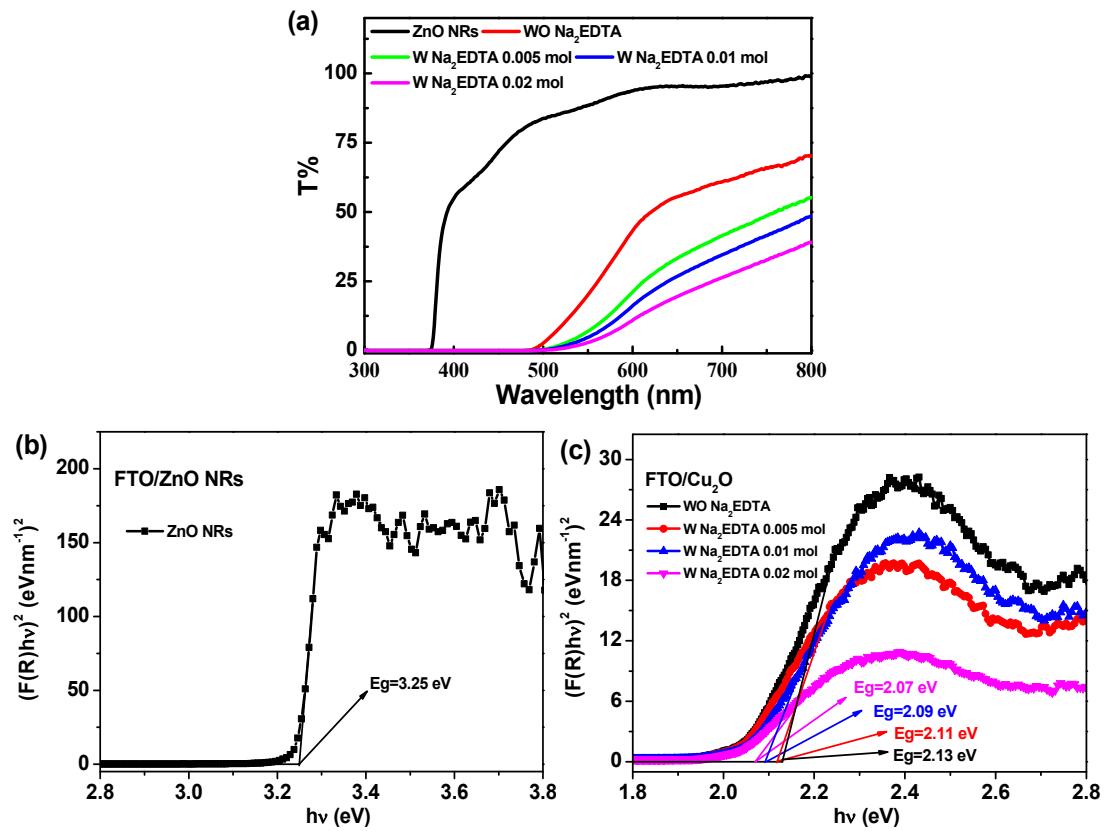


Fig.S4 (a) Transmission spectra of ZnO NRs and ZnO/Cu₂O heterojunction with different Na₂EDTA additions. Optical band-gaps of (b) ZnO NRs and (c) Cu₂O thin films deposited with different Na₂EDTA additions calculated by diffuse reflectance spectroscopy

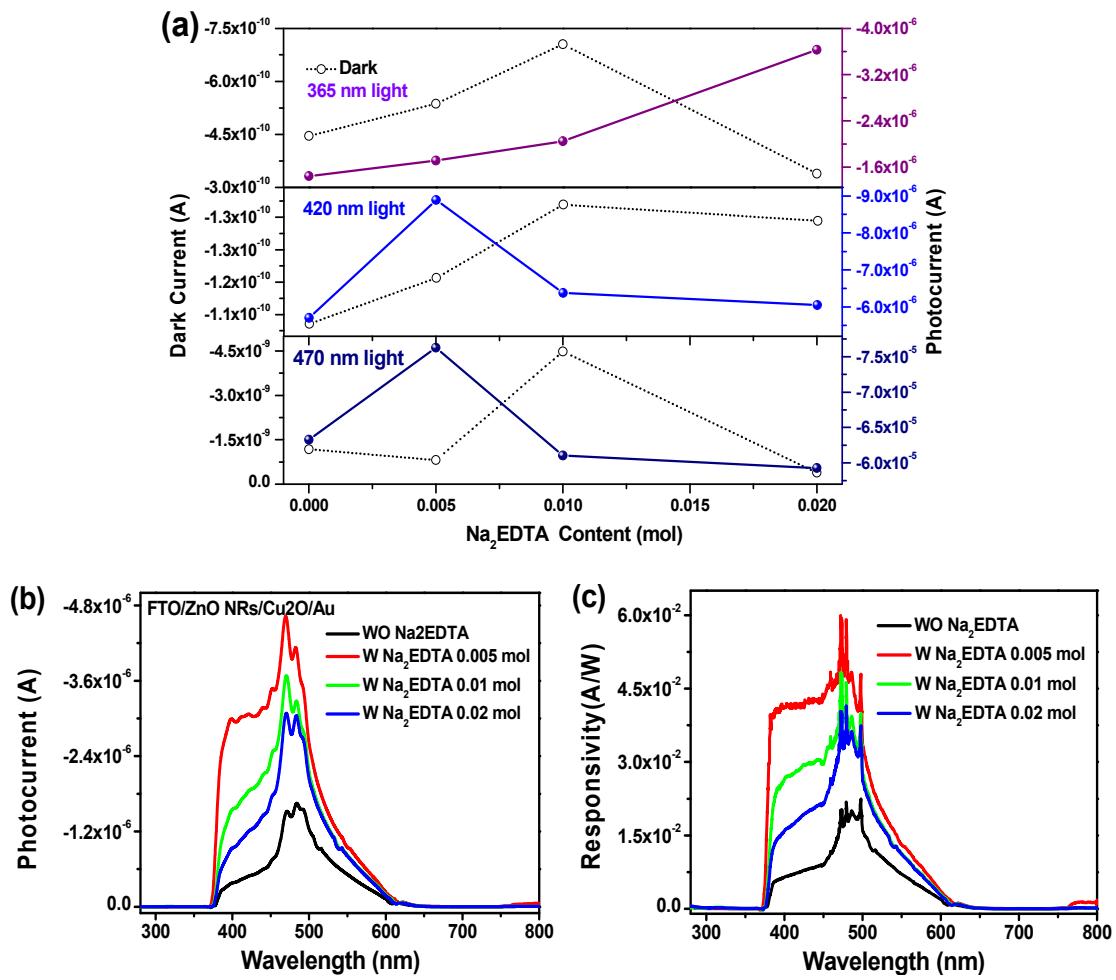


Fig.S5 (a) Photocurrent and dark state current curves of ZnO NRs/Cu₂O heterostructure devices with different Na₂EDTA contents under UV and visible light irradiation. (b) Photocurrent and (c) responsivity under different light wavelengths for the devices with different Na₂EDTA content

Table 2 The information of energy level of ZnO NRs and Cu₂O films with different Na₂EDTA additions.

Samples (Na ₂ EDTA content)	E _C (eV)	E _V (eV)	E _g (eV)	E _F (eV)	ΔE _C (eV)	ΔE _V (eV)
0	-3.43	-5.56	2.13	-5.19	1.01	2.13
0.005 mol	-3.39	-5.50	2.11	-5.23	1.05	2.19
0.01 mol	-3.38	-5.47	2.09	-5.22	1.06	2.22
0.02 mol	-3.32	-5.39	2.07	-5.21	1.12	2.3
ZnO NRs	-4.44	-7.69	3.25	-4.80	-	-

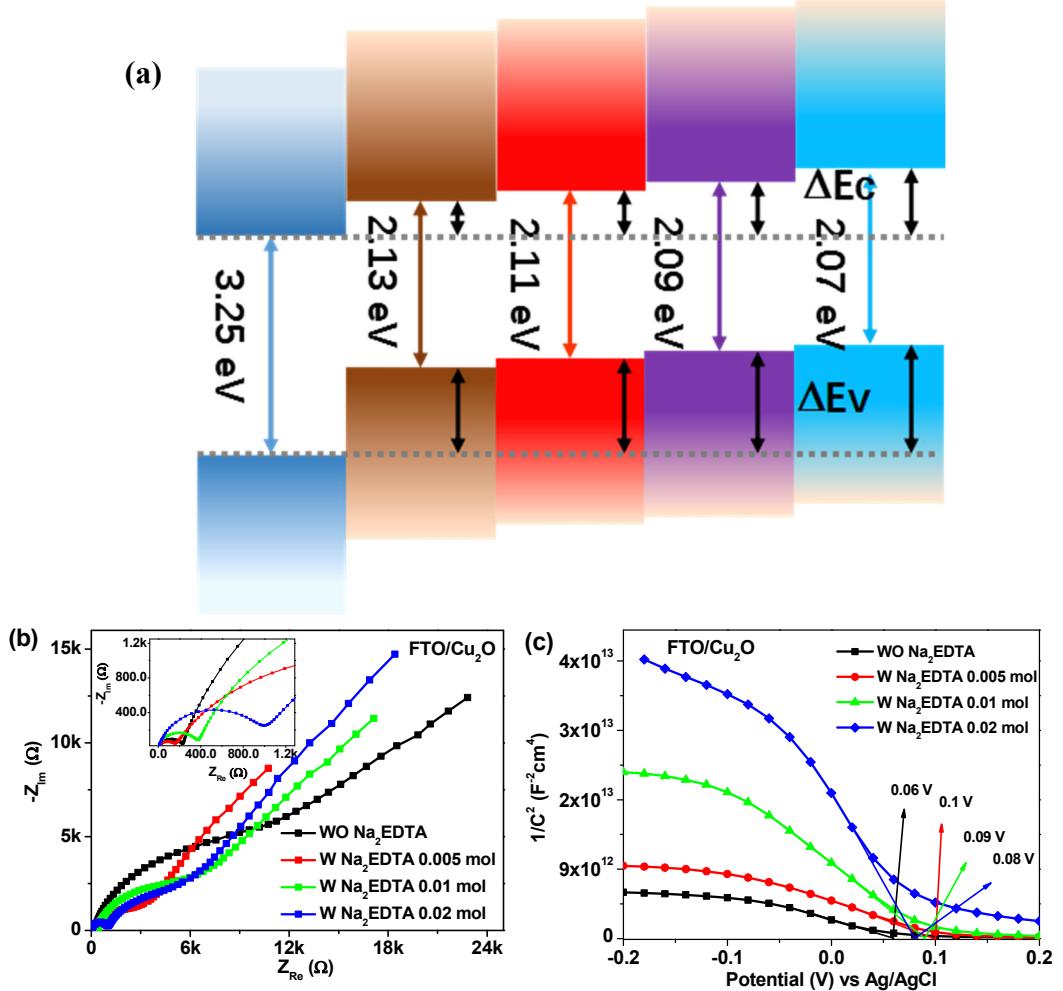


Fig.S6 (a) Schematic diagram of type-II band alignment of ZnO/Cu₂O heterojunction films. (b) EIS spectra and (c) M-S curves of Cu₂O thin films with different Na₂EDTA additions

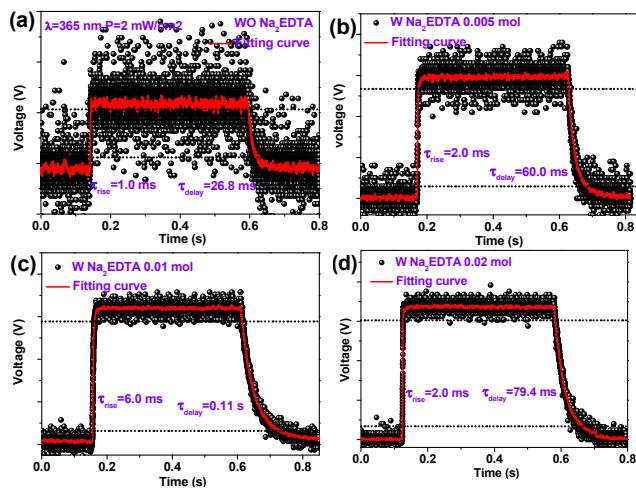


Fig.S7 Photoresponse speed of ZnO NRs/Cu₂O heterojunction devices with different Na₂EDTA additions under 365 nm illumination.

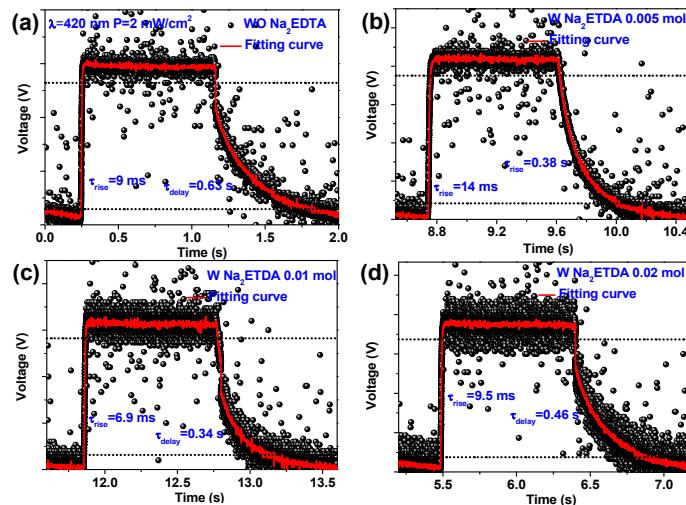


Fig.S8 Photoresponse speed of ZnO NRs/Cu₂O heterojunction devices with different Na₂EDTA additions under 420 nm illumination.

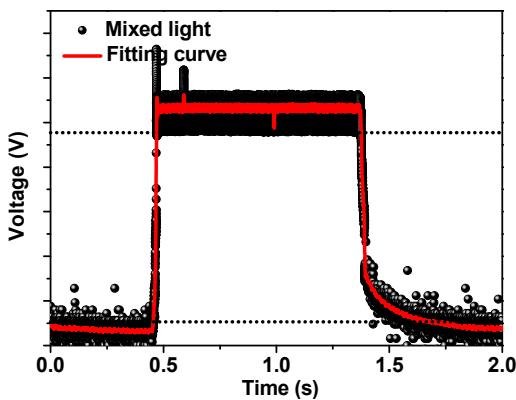


Fig.S9 Photoresponse speed of ZnO NRs/Cu₂O heterojunction device with 0.005 mol Na₂EDTA addition under UV and visible mixed light illumination.

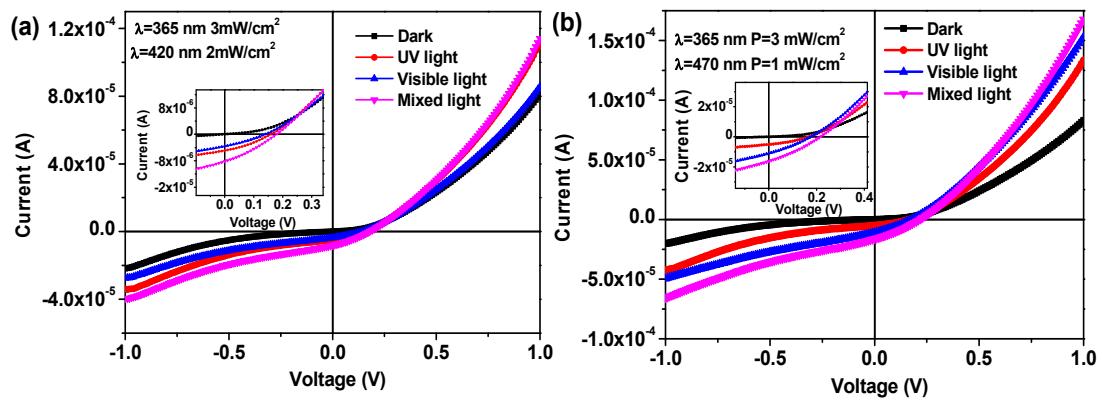


Fig.S9 I-V curve of ZnO NRs/Cu₂O PD under UV and visible monochromatic light and the mixed light illumination.